



IDT08S60C

2nd Generation thinQ!TM SiC Schottky Diode

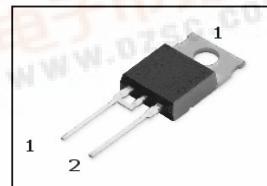
Features

- Revolutionary semiconductor material - Silicon Carbide
- Switching behavior benchmark
- No reverse recovery/ No forward recovery
- No temperature influence on the switching behavior
- High surge current capability
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC¹⁾ for target applications
- Breakdown voltage tested at 5mA²⁾

Product Summary

V_{DC}	600	V
Q_c	19	nC
I_F	8	A

PG-T0220-2-2



thinQ! 2G Diode specially designed for fast switching applications like:

- CCM PFC
- Motor Drives

Type	Package	Marking	Pin 1	Pin 2
IDT08S60C	PG-T0220-2-2	D08S60C	C	A

Maximum ratings, at $T_j=25$ °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous forward current	I_F	$T_C < 140$ °C	8	A
RMS forward current	$I_{F,RMS}$	$f=50$ Hz	12	
Surge non-repetitive forward current, sine halfwave	$I_{F,SM}$	$T_C = 25$ °C, $t_p = 10$ ms	59	
Repetitive peak forward current	$I_{F,RM}$	$T_j = 150$ °C, $T_C = 100$ °C, $D = 0.1$	32	
Non-repetitive peak forward current	$I_{F,max}$	$T_C = 25$ °C, $t_p = 10$ μs	264	
i^2t value	$\int i^2 dt$	$T_C = 25$ °C, $t_p = 10$ ms	17	A ² s
Repetitive peak reverse voltage	V_{RRM}		600	V
Diode dv/dt ruggedness	dv/dt	$V_R = 0 \dots 480$ V	50	V/ns
Power dissipation	P_{tot}	$T_C = 25$ °C	75	W
Operating and storage temperature	T_j, T_{stg}		-55 ... 175	°C
Mounting torque		M3 and M3.5 screws	60	Ncm



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Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - case	R_{thJC}		-	-	2	K/W
Thermal resistance, junction - ambient	R_{thJA}	leaded	-	-	62	
Soldering temperature, wavesoldering only allowed at leads	T_{sold}	1.6mm (0.063in.) from case for 10s	-	-	260	°C

Electrical characteristics, at $T_j=25$ °C, unless otherwise specified

Static characteristics

DC blocking voltage	V_{DC}	$I_R=0.1$ mA	600	-	-	V
Diode forward voltage	V_F	$I_F=8$ A, $T_j=25$ °C	-	1.5	1.7	
		$I_F=8$ A, $T_j=150$ °C	-	1.7	2.1	
Reverse current	I_R	$V_R=600$ V, $T_j=25$ °C	-	1	100	μA
		$V_R=600$ V, $T_j=150$ °C	-	4	1000	

AC characteristics

Total capacitive charge	Q_c	$V_R=400$ V, $I_F \leq I_{F,max}$, $di_F/dt=200$ A/μs, $T_j=150$ °C	-	19	-	nC
Switching time ³⁾	t_c	$V_R=1$ V, $f=1$ MHz	-	-	<10	ns
	-		310	-	pF	
	-		50	-		

¹⁾ J-STD20 and JESD22

²⁾ All devices tested under avalanche conditions, for a time period of 5ms, at 5 mA.

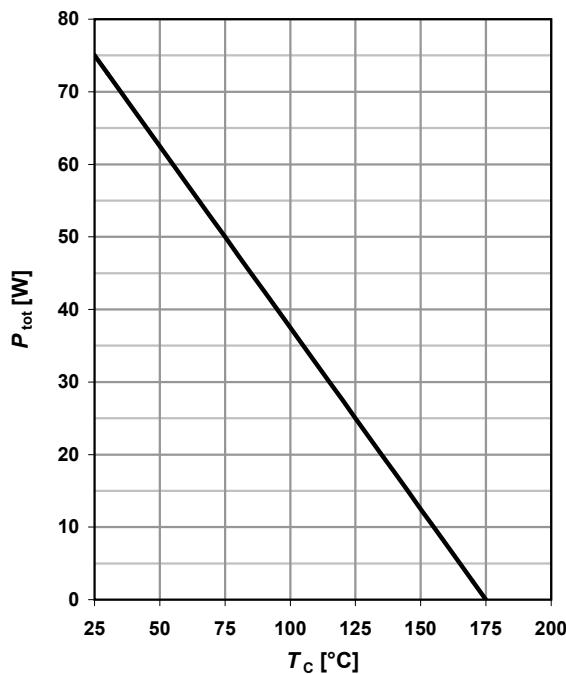
³⁾ t_c is the time constant for the capacitive displacement current waveform (independent from T_j , I_{LOAD} and di/dt), different from t_r which is dependent on T_j , I_{LOAD} and di/dt . No reverse recovery time constant t_r due to absence of minority carrier injection.

⁴⁾ Only capacitive charge occurring, guaranteed by design

1 Power dissipation

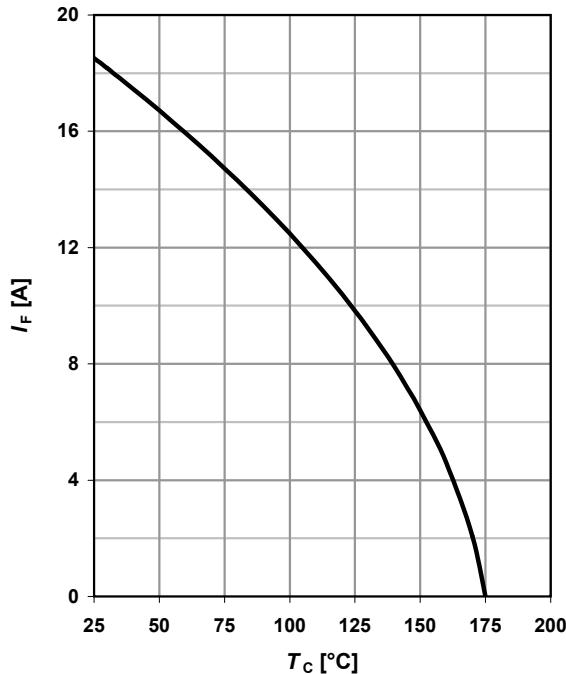
$$P_{\text{tot}} = f(T_c)$$

parameter: $R_{\text{thJC(max)}}$


2 Diode forward current

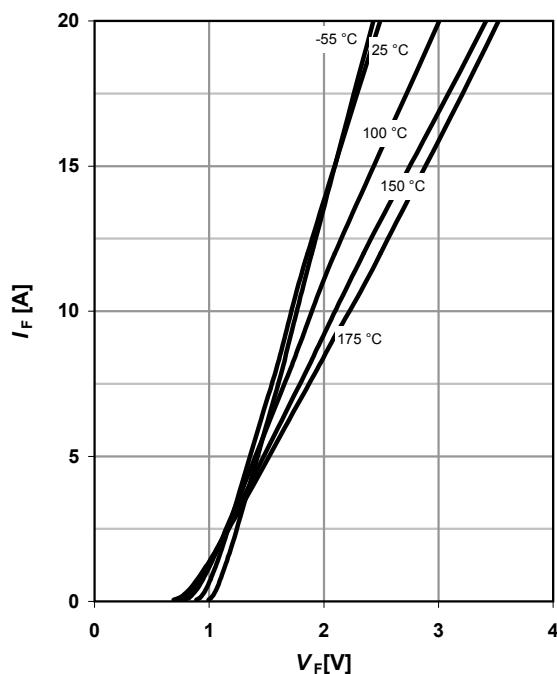
$$I_F = f(T_c); T_j \leq 175 \text{ °C}$$

parameter: $R_{\text{thJC(max)}}; V_{F(\text{max})}$

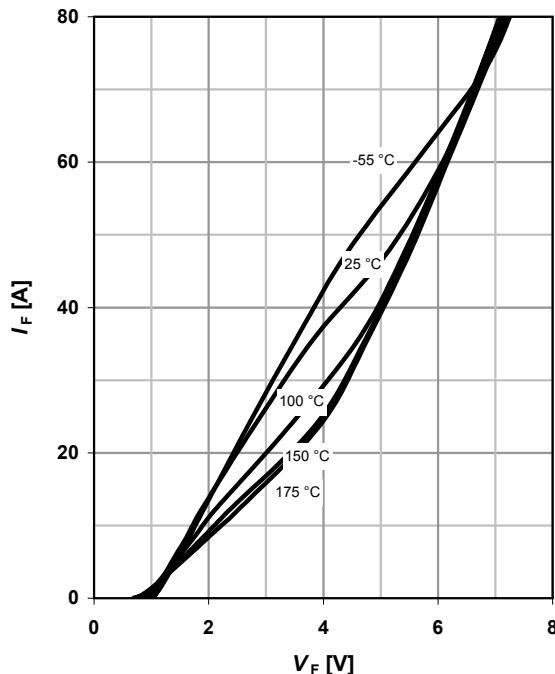

3 Typ. forward characteristic

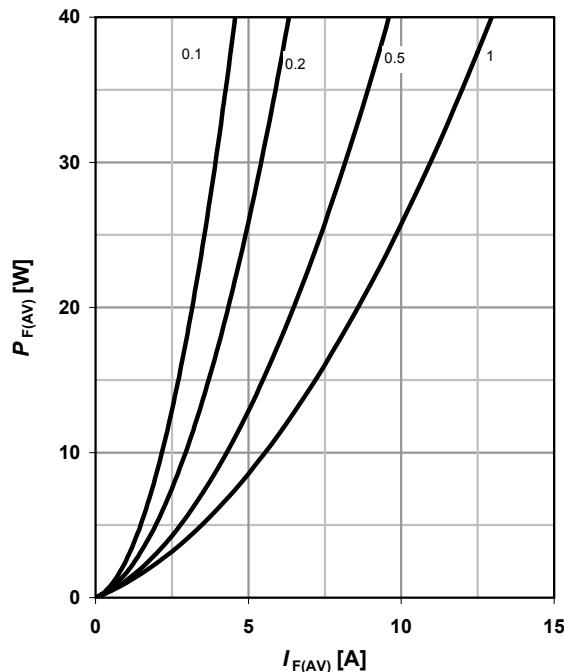
$$I_F = f(V_F); t_p = 400 \mu\text{s}$$

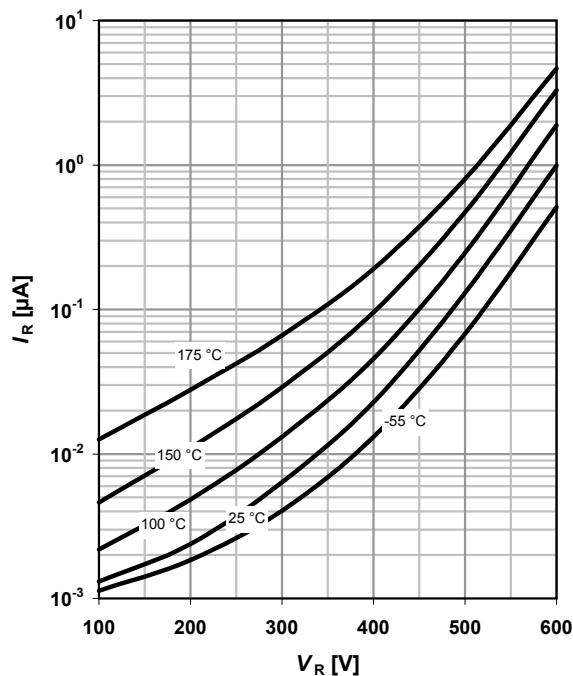
parameter: T_j

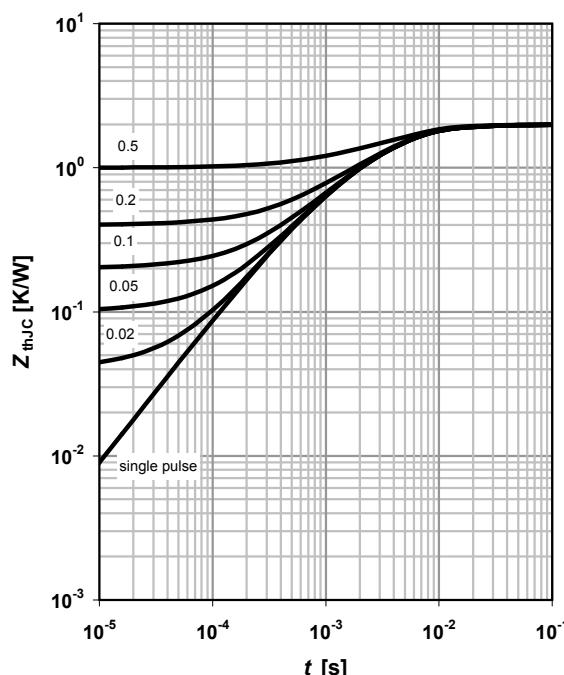
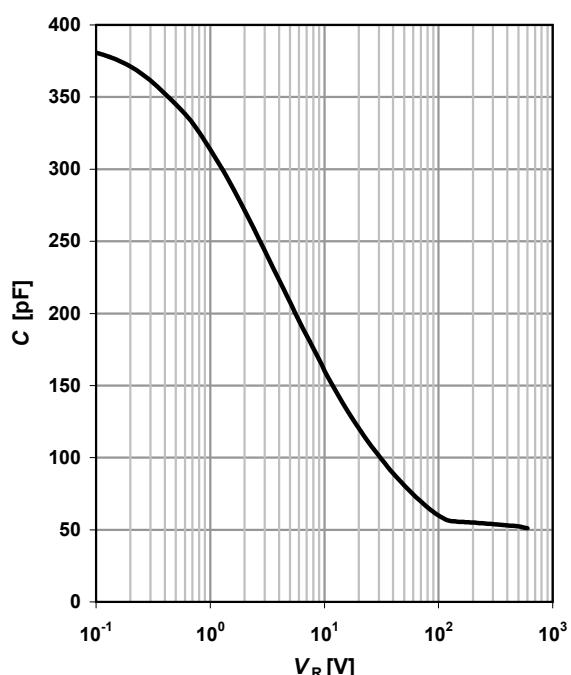

4 Typ. forward characteristic in surge current mode

$$I_F = f(V_F); t_p = 400 \mu\text{s}; \text{ parameter: } T_j$$



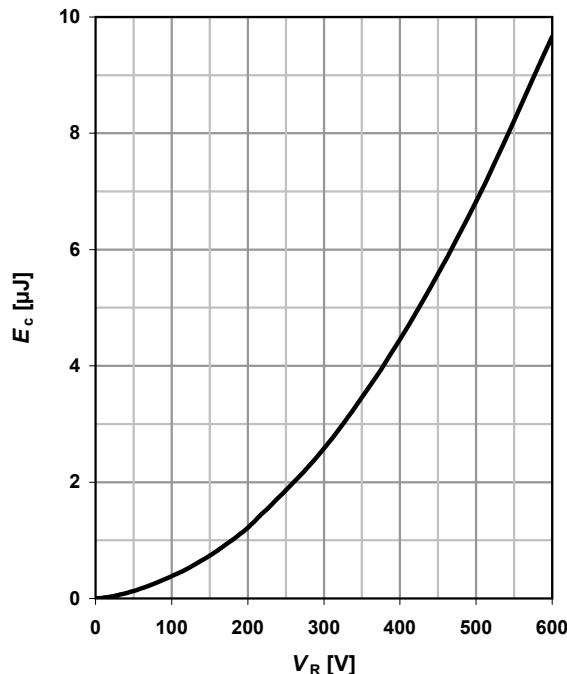
5 Typ. forward power dissipation vs.
average forward current
 $P_{F,AV}=f(I_F)$, $T_C=100\text{ }^\circ\text{C}$, parameter: $D=t_p/T$

6 Typ. reverse current vs. reverse voltage
 $I_R=f(V_R)$

parameter: T_j

7 Transient thermal impedance
 $Z_{thJC}=f(t_p)$

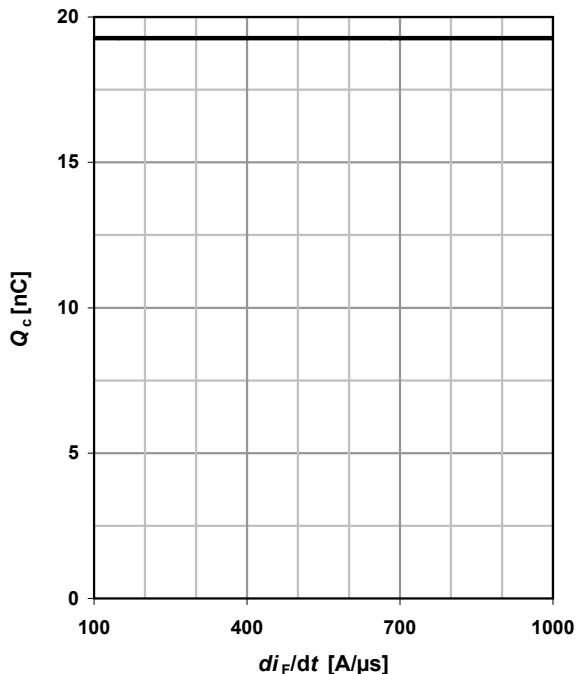
parameter: $D=t_p/T$

8 Typ. capacitance vs. reverse voltage
 $C=f(V_R)$; $T_C=25\text{ }^\circ\text{C}$, $f=1\text{ MHz}$


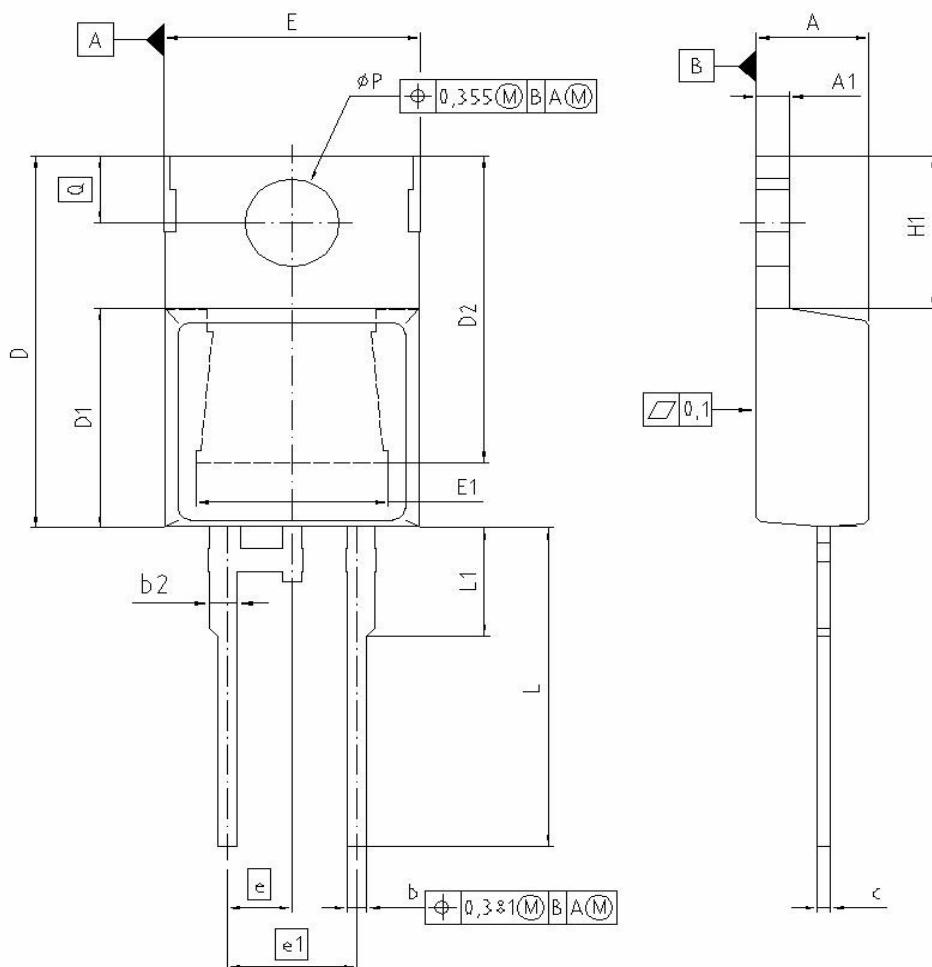
9 Typ. C stored energy

$$E_c = f(V_R)$$

**10 Typ. capacitance charge vs. current slope**

$$Q_c = f(di_F/dt)^4; T_J = 150^\circ\text{C}; I_F \leq I_{F,\max}$$



Package Outline: PG-T0220-2-2


DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.191	4.699	0.165	0.185
A1	1.170	1.400	0.046	0.055
A2	2.215	2.718	0.087	0.107
b	0.635	0.889	0.025	0.035
b2	0.950	1.651	0.037	0.065
c	0.330	0.635	0.013	0.025
D	14.808	15.950	0.583	0.628
D1	8.509	9.450	0.335	0.372
D2	12.850	14.245	0.506	0.561
E	9.677	10.363	0.381	0.408
E1	6.500	8.788	0.256	0.346
e	2.540		0.100	
e1	5.080		0.200	
N	2		2	
H1	5.900	6.900	0.232	0.272
L	12.700	14.000	0.500	0.551
L1	3.048	4.800	0.120	0.189
ØP	3.550	3.886	0.140	0.153
Q	2.540	3.048	0.100	0.120

REFERENCE	...J...
SCALE	0 2.5 0 2.5 5mm
EUROPEAN PROJECTION	
ISSUE DATE	04-10-2005
FILE	TO220_3



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